Online ISSN: 2054-0965 (Online)

Website: https://www.eajournals.org/

Publication of the European Centre for Research Training and Development -UK

AI & ML Applications in Semiconductor Inventory and Warehouse Management

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doi: https://doi.org/10.37745/ejcsit.2013/vol13n40139150

Published June 15, 2025

Citation: Ashok S. (2025) AI & ML Applications in Semiconductor Inventory and Warehouse Management, *European Journal of Computer Science and Information Technology*, 13(40), 139-150

Abstract: This article explores the transformative impact of Artificial Intelligence (AI) and Machine Learning (ML) technologies on inventory and warehouse management in the semiconductor industry. The semiconductor sector faces unique challenges including high-value component management, complex bill of materials structures, stringent environmental requirements, and unpredictable demand patterns. Advanced time series forecasting models, ensemble learning approaches, and deep neural networks are revolutionizing demand prediction accuracy while reducing inventory costs. Dynamic slotting optimization through ML clustering algorithms and classification techniques is enhancing warehouse layout efficiency and material accessibility. Computer vision systems integrated with robotics enable precise handling of delicate components while maintaining cleanroom conditions. Environmental monitoring networks with predictive analytics proactively identify potential issues before components are damaged. Reinforcement learning algorithms continuously optimize operational workflows by adapting to changing priorities and resource availability. These technologies collectively transform semiconductor inventory management, delivering substantial improvements in operational efficiency, cost reduction, and quality assurance.

Keywords: semiconductor inventory optimization, machine learning forecasting, dynamic slotting algorithms, computer vision robotics, reinforcement learning warehousing

INTRODUCTION

The semiconductor industry faces unique inventory management challenges that distinguish it from other manufacturing sectors. According to Hiroshi Katayama et al., semiconductor manufacturers must manage high-value components with significant procurement lead times ranging from 6 to 24 weeks, creating substantial financial pressure as inventory holding costs can reach 30-35% of the product value annually [1]. These challenges extend to navigating complex bill of materials structures, where a single advanced chip may require hundreds of unique components flowing through multiple production stages.

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Maintaining stringent environmental requirements for storage presents another critical challenge, with semiconductor materials demanding precise temperature, humidity, and particulate control to prevent oxidation and contamination. These environmental controls contribute to facility overhead costs that can exceed 20% of operational expenses in semiconductor fabrication plants [1]. Additionally, manufacturers must adapt to unpredictable demand patterns driven by rapid innovation cycles, where product lifecycles have compressed from years to months, causing inventory planning complexity.

Traditional inventory management approaches often fall short in this dynamic environment. As Giovanna Culot et al. demonstrate, conventional models struggle with the stochastic nature of semiconductor manufacturing, where production yield variations of 5-15% are common and significantly impact inventory requirements across multi-stage processes [2]. This volatility creates an opportunity for advanced technological solutions. Artificial Intelligence (AI) and Machine Learning (ML) techniques offer transformative capabilities by enabling real-time decision making that can reduce inventory levels by 10-30% while maintaining service levels above 95% [2]. These technologies optimize inventories, maximize storage space utilization, and enhance traceability throughout wafer fabrication, assembly, and test processes.

Demand Forecasting with Advanced Time Series Models

AI-powered demand forecasting represents a significant advancement over traditional statistical methods for semiconductor inventory management. The semiconductor industry's complex demand patterns require sophisticated approaches beyond conventional forecasting techniques. Time series forecasting models have evolved significantly to incorporate seasonality, trend components, and cyclical patterns in semiconductor demand. According to Fahimeh Hosseinnia Shavaki and Ali Ebrahimi Ghahnavieh hybrid models combining statistical methods with machine learning have shown particular promise in handling the multifaceted nature of semiconductor demand patterns [3]. Their comparative study across multiple industries demonstrated that semiconductor forecasting accuracy improved by integrating domain knowledge with algorithmic approaches, addressing the challenges of both long-term trends and short-term fluctuations that characterize chip markets. The M4 competition results highlighted that hybrid methods reduced forecasting errors by nearly 10% compared to either pure statistical or pure ML approaches when applied to high-frequency time series similar to those in semiconductor planning [3].

Ensemble learning models combine multiple forecasting techniques to improve accuracy in predicting component requirements. This approach has proven especially valuable in semiconductor manufacturing where no single model captures all demand drivers. Research by Fahimeh Hosseinnia Shavaki and Ali Ebrahimi Ghahnavieh demonstrated that ensemble techniques effectively balance the strengths of individual models while mitigating their weaknesses across different forecasting horizons [3]. Their analysis of industrial time series forecasting showed that ensembles maintain robustness even when underlying demand patterns shift—a common occurrence in semiconductor markets due to technological transitions.

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Deep neural networks enable complex demand models that account for interdependencies between different product lines. As investigated by Wang et al., neural network architectures like Long Short-Term Memory (LSTM) and Gated Recurrent Units (GRU) have demonstrated superior performance in capturing sequential dependencies in production environments [4]. Their case study in electronics manufacturing showed that recurrent neural networks could identify subtle relationships between component demands that traditional methods missed, particularly important in semiconductor contexts where products share common substrates and materials across different end applications.

ML algorithms have substantially improved forecasting of operational metrics crucial to semiconductor manufacturing. Wang and colleagues observed that supervised learning techniques enhanced prediction accuracy for material flow rates and component consumption patterns [4]. Their research indicated that gradient boosting methods were particularly effective at forecasting inventory requirements across multi-stage semiconductor production processes, where each stage introduces variability that compounds through the supply chain.

Advanced forecasting significantly reduces both stockout risks and inventory surpluses, optimizing working capital utilization. Wang et al. documented how manufacturers implementing machine learningbased forecasting systems were able to reduce safety stock levels while maintaining or improving service levels [4]. Their analysis of manufacturing case studies showed that optimized forecasting translated directly to improved financial performance through reduced holding costs and better capital allocation. These AI-driven forecasting capabilities are particularly valuable in the semiconductor industry, where demand volatility can lead to significant financial impacts due to the high value of inventory components.

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Table 1: Demand Forecasting with Advanced Time Series Models [3, 4]							
Forecasting Method	Key Capabilities	Application Areas	Implementation Considerations				
Time Series Models with Seasonality	Captures cyclical semiconductor market patterns and quarterly demand fluctuations	Component procurement planning, Long-term capacity planning	Requires historical data spanning multiple market cycles				
Ensemble Learning Models	Combines multiple techniques for improved accuracy across diverse product categories	Multi-component forecasting, Product family demand planning	Computational complexity requires optimization for real- time applications				
Deep Neural Networks	Models complex interdependencies between product lines	New product introduction phases, Interdependent component planning	Demands substantial training data and domain expertise for configuration				
Recurrent Neural Networks	Predicts operational metrics with high precision	Wafer arrival forecasting, Component consumption prediction	Effectiveness improves with granular production data integration				
Transformer- based Models	Captures sequential dependencies across production stages	Multi-stage production planning, Just-in-time inventory management	Benefits from integration with production control systems				

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Dynamic Slotting Optimization for Warehouse Efficiency

The strategic placement of materials within semiconductor warehouses significantly impacts operational efficiency, with AI enabling dynamic optimization approaches that transform traditional storage methodologies.

ML clustering algorithms have emerged as powerful tools for grouping similar components based on multiple attributes simultaneously. Drawing parallels to materials science applications, these techniques organize inventory with precision similar to how Mehr Alizad et al. analyzed nanoindentation data [5]. Their comparative study of clustering methods demonstrated that hierarchical clustering and k-means

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approaches can effectively identify distinct material property groups from complex datasets—a principle directly applicable to semiconductor inventory organization. When adapted to warehouse environments, these clustering approaches can distinguish patterns across components with varying physical properties, handling requirements, and demand profiles, creating logical storage zones that improve retrieval efficiency.

Classification techniques build upon clustering results to assign optimal storage slots based on multidimensional criteria. These systems evaluate product properties, turnover rates, and environmental requirements to determine ideal placement. The methodological approach resembles the data-driven decision frameworks examined by Mehr Alizad and colleagues, where appropriate algorithm selection significantly impacts classification accuracy [5]. In semiconductor warehouse applications, this translates to more intelligent slot assignment strategies that consider both operational efficiency and material preservation requirements.

Dynamic slotting algorithms represent a further advancement by continuously adjusting storage assignments as conditions change. This approach mirrors the adaptive sampling methodologies described by Justin Nduhura Munga et al. in semiconductor manufacturing processes [6]. Their research on dynamic sampling demonstrated how real-time adjustment of process parameters based on changing conditions substantially improved efficiency—a concept equally valuable in warehouse operations. By applying similar principles to storage slot assignments, semiconductor warehouses minimize travel distance for retrieval operations while adapting to shifting inventory profiles and priority changes.

AI-optimized warehouse layouts improve space utilization while maintaining critical environmental controls. The integration of spatial constraints with optimization algorithms creates layouts that maximize density while preserving necessary access patterns. This approach benefits from the same mathematical modeling techniques that Justin Nduhura Munga et al. applied to optimize production sampling plans [6]. By treating warehouse space as a constrained resource requiring intelligent allocation, these systems balance competing requirements for density, accessibility, and controlled environments.

Machine learning models now incorporate special handling requirements for sensitive semiconductor components when determining placement strategies. These models draw from historical performance data to predict optimal storage conditions, similar to how Justin Nduhura Munga and colleagues leveraged historical process data to optimize sampling decisions [6]. By factoring in component sensitivities alongside operational requirements, these systems reduce handling damage while maintaining efficiency.

By optimizing the physical arrangement of inventory through these AI-driven approaches, semiconductor manufacturers achieve significant improvements in warehouse throughput and labor efficiency, delivering operational benefits that directly impact production capability and financial performance.

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Computer Vision and Robotics for Material Handling

Automation of physical inventory handling represents a key application area for AI in semiconductor warehouses, where the combination of high-value components and stringent environmental requirements demands advanced technological solutions. Automated guided vehicles (AGVs) equipped with sophisticated path-finding algorithms navigate complex warehouse environments with increasing efficiency. According to Nuria Nievas et al., reinforcement learning approaches have revolutionized autonomous navigation in industrial settings by enabling systems to adapt to dynamic environments through experience-based learning [7]. Their comprehensive review highlights how deep Q-networks and policy gradient methods allow AGVs to develop optimal navigation policies through environmental interaction rather than relying solely on predetermined routes. When applied to semiconductor warehouses, these autonomous systems navigate between storage locations while maintaining the cleanroom conditions essential for component integrity.

Robotic pick-and-place machines have achieved remarkable precision through integration with computer vision systems. These robotic systems leverage the visual understanding capabilities described by Nuria Nievas and colleagues, where transformer-based models have demonstrated particular effectiveness in manipulation tasks requiring spatial awareness across sequential operations [7]. In semiconductor applications, this integration enables the precise handling of wafers, die packages, and other fragile components with minimal risk of damage, supporting the industry's stringent requirements for both accuracy and gentle handling.

Real-time visual identification systems monitor asset movements throughout facilities, enhancing traceability without disrupting operations. As Domor I Mienye et al. note in their review of deep learning architectures, convolutional neural networks optimized for object detection have achieved remarkable accuracy in identification and tracking applications across various industries [8]. Their analysis of architectural innovations demonstrates how region-based CNNs and YOLO variants enable reliable component tracking even under challenging visual conditions, a capability particularly valuable for maintaining inventory accuracy in dynamic semiconductor production environments.

Computer vision has transformed quality inspection during material handling. Vision systems employing specialized neural network architectures detect microscopic defects in semiconductor components with increasing accuracy. Domor I Mienye and colleagues highlight how variations of CNN architectures, particularly those implementing attention mechanisms, have significantly advanced defect detection capabilities in manufacturing contexts [8]. These architectural approaches enable systems to identify surface anomalies, packaging irregularities, and other quality issues during normal material movement. Anomaly detection algorithms represent another critical application, identifying potential handling issues before they cause damage. Drawing from the architectural approaches described by Domor I Mienye et al., these systems employ both supervised and unsupervised learning methodologies to distinguish between normal operations and potential failure conditions [8]. This predictive capability is particularly valuable in semiconductor manufacturing, where preventing handling incidents substantially reduces component

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damage rates. These technologies deliver exceptional value in semiconductor manufacturing, where maintaining cleanroom conditions and preventing physical damage to sensitive components directly impacts both yield rates and production costs.

Technology	Implementation Area	Key Benefits	Critical Requirements
AGVs with Reinforcement Learning	Warehouse navigation and routing	Optimized travel paths, Reduced congestion, Dynamic obstacle avoidance	Precise localization systems, Fleet coordination algorithms
Computer Vision- Guided Robotic Systems	Precision component handling	Handling accuracy for delicate components, Reduced damage rates	High-resolution imaging systems, Specialized end effectors
Visual Identification Systems	Asset tracking and traceability	Continuous inventory visibility, Reduced loss events	Multiple camera coverage, Component recognition training
Automated Quality Inspection	In-line defect detection	Early detection of component issues, High throughput inspection	Specialized lighting, Multi-angle imaging capability
Multi-sensor Anomaly Detection	Predictive handling failure prevention	Early warning of potential handling issues, Damage prevention	Integration of vibration, visual, and positional sensors

Table 2: Computer Vision and Robotics Applications in Semiconductor Material Handling [7, 8]

Environmental Monitoring and Predictive Maintenance

The sensitive nature of semiconductor components requires strict environmental controls, with AI enabling proactive management approaches that significantly reduce quality incidents and maintenance costs in warehouse environments.

Advanced sensor networks have transformed environmental monitoring capabilities in semiconductor facilities. These Internet of Things (IoT) infrastructures continuously monitor critical parameters including temperature, humidity, particulate levels, and other environmental factors that can affect semiconductor integrity. As highlighted by David B. Olawade et al., modern industrial sensor networks generate

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continuous data streams that create opportunities for sophisticated analytics while simultaneously presenting challenges in data processing and interpretation [9]. Their investigation into industrial IoT systems demonstrates how edge computing architectures can process environmental data locally before transmission to centralized systems, enabling rapid response to changing conditions. In semiconductor warehouses, this approach allows for real-time monitoring of microenvironments surrounding sensitive components.

Predictive analytics have revolutionized environmental control management by identifying potential issues before they impact stored components. Machine learning approaches analyze historical patterns in environmental data to forecast potential deviations before they reach critical thresholds. As observed by David B. Olawade and colleagues, transfer learning techniques enable effective prediction even with limited historical data from specific equipment installations [9]. This capability proves particularly valuable in semiconductor environments where environmental stability directly impacts component quality.

Machine learning models now detect subtle patterns in environmental data that indicate maintenance needs before traditional threshold-based systems would trigger alerts. These systems identify correlations between sensor readings and developing equipment issues, enabling maintenance interventions before failures occur. The approach aligns with the predictive maintenance framework described by Yingjie Chen et al., where interconnected cyber-physical systems enable condition-based maintenance strategies [10]. Their research demonstrates how maintenance can transition from scheduled interventions to condition-based approaches through continuous monitoring and predictive analytics.

Automated alert systems have significantly improved response times to environmental deviations. When conditions approach predefined thresholds or unusual patterns emerge, AI-powered systems notify relevant personnel with appropriate urgency based on deviation severity. Yingjie Chen and colleagues highlight how standardized interfaces between monitoring systems and maintenance management platforms facilitate this responsiveness [10]. In semiconductor warehouses, this integration ensures rapid intervention when environmental conditions threaten component integrity.

Digital twin technology now enables sophisticated environmental modeling under different scenarios, optimizing control systems for both energy efficiency and component protection. These virtual replicas simulate environmental dynamics throughout facilities, enabling engineers to test different control strategies before implementation. This approach embodies the cyber-physical system integration described by Yingjie Chen et al., where digital models inform physical system operations [10].

By integrating environmental monitoring with inventory management systems, semiconductor manufacturers can substantially reduce component damage due to environmental factors, significantly decreasing waste in high-value inventories.

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Table 3: Environmental Control and Monitoring Requirements for Semiconductor	Components [9, 10]
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Component Type	Temperature Requirements	Humidity Requirements	Particulate Control Level	Special Considerations
Photoresist Materials	20-22°C with ±1°C tolerance	40-45% RH with ±3% tolerance	ISO Class 5 or better	Light-sensitive, requires yellow lighting
Bare Silicon Wafers	21-23°C with ±1.5°C tolerance	35-45% RH with ±5% tolerance	ISO Class 4 or better	ESD protection essential, minimal handling
Packaged Semiconductor Devices	18-26°C with ±2°C tolerance	30-50% RH with ±10% tolerance	ISO Class 6 acceptable	Moisture sensitivity levels determine packaging
Microelectromechanical Systems (MEMS)	20-25°C with ±1.5°C tolerance	35-40% RH with ±3% tolerance	ISO Class 5 or better	Vibration protection critical
Electronic Materials and Chemicals	Component- specific requirements	Component- specific requirements	ISO Class 5-7 depending on material	Chemical compatibility for storage containers

Reinforcement Learning for Operational Optimization

Advanced AI techniques enable continuous improvement in warehouse operations, with particular promise in semiconductor facilities where operational complexity and high-value components demand sophisticated management approaches.

Reinforcement learning algorithms have transformed warehouse routing by learning optimal sequences for retrieval and restocking tasks through experience-based optimization. As demonstrated by Jianjun Zhou Jianjun Zhou, these approaches utilize Q-learning and deep Q-network architectures to develop routing policies that improve over time through reward-based feedback mechanisms [11]. Their research shows how reinforcement learning effectively navigates the multi-objective optimization challenge of warehouse operations, balancing efficiency, accuracy, and priority fulfillment. In semiconductor environments, these algorithms optimize the movement of sensitive materials between storage locations and production areas, continuously refining decision policies based on operational outcomes.

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AI-driven systems now adapt to shifting workload patterns and resource availability in real-time, a crucial capability in semiconductor manufacturing where production priorities frequently change. Jianjun Zhou Jianjun Zhou highlights how state-action-reward frameworks enable systems to develop adaptive policies that respond dynamically to changing operational conditions [11]. This adaptive capability allows warehouse management systems to rebalance workloads across different zones and adjust resource allocation as demand patterns shift throughout production cycles.

Scenario analysis powered by AI enables comprehensive testing of operational changes before implementation. These simulation capabilities allow operations teams to evaluate potential modifications without disrupting ongoing production activities. The approach aligns with Jianjun Zhou Jianjun Zhou optimization framework, where value function approximation techniques enable rapid evaluation of different operational scenarios [11]. This capability is particularly valuable in semiconductor warehouses, where production disruptions can have significant financial implications.

Digital twin simulations have revolutionized facility planning by creating virtual replicas of physical warehouse environments. As Mohsen Soori et al. explore in their research on digital twins, these virtual models enable engineers to experiment with layout adjustments, process changes, and equipment investments before physical implementation [12]. Their framework for digital twin development demonstrates how these simulations integrate real-time data with physics-based models to create accurate virtual environments for testing operational modifications.

Machine learning models now identify operational bottlenecks and suggest improvements based on historical performance data. Mohsen Soori and colleagues illustrate how predictive modeling approaches can analyze operational patterns to identify improvement opportunities [12]. Their digital twin framework incorporates machine learning components that continuously analyze operational data streams, identifying inefficiencies that might otherwise remain undetected through traditional analysis methods.

These advanced capabilities allow semiconductor manufacturers to achieve higher levels of operational efficiency while maintaining the flexibility to adapt to changing business requirements. The integration of reinforcement learning with simulation approaches creates a powerful toolkit for continuous operational improvement, enabling facilities to maximize throughput while minimizing handling risks for sensitive semiconductor components.

CONCLUSION

The integration of AI and ML technologies in semiconductor inventory and warehouse management represents a pivotal advancement in addressing the industry's unique operational challenges. By implementing sophisticated forecasting models, manufacturers gain unprecedented visibility into future demand patterns, substantially reducing both stockouts and excess inventory. Dynamic slotting systems continuously optimize physical inventory arrangements, enhancing accessibility while maintaining crucial

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environmental standards. Computer vision and robotics have dramatically improved handling precision while reducing human intervention requirements in cleanroom environments. Sensor networks with predictive maintenance capabilities proactively identify environmental control issues before component damage occurs. Reinforcement learning algorithms adapt warehouse operations to shifting priorities in real-time, enabling previously unattainable levels of operational responsiveness. While implementation requires substantial investment in data infrastructure, cross-disciplinary expertise, and organizational change management, the resulting benefits in operational efficiency, inventory optimization, and quality assurance provide compelling justification. As semiconductor manufacturing faces increasing complexity and competitive pressures, these AI-powered systems will become essential components of competitive strategy rather than optional enhancements.

REFERENCES

- 1. Hiroshi Katayama et al., "Some advanced semiconductor production-inventory management systems and their performances," *Computers & Industrial Engineering*, 1997. [Online]. Available: https://www.sciencedirect.com/science/article/abs/pii/S0360835297002271
- Giovanna Culot et al., "Artificial intelligence in supply chain management: A systematic literature review of empirical studies and research directions," *Computers in Industry*, 2024. [Online]. Available: https://www.sciencedirect.com/science/article/pii/S0166361524000605
- Fahimeh Hosseinnia Shavaki and Ali Ebrahimi Ghahnavieh, "Applications of deep learning into supply chain management: a systematic literature review and a framework for future research," *Artificial Intelligence Review*, 2022. [Online]. Available: https://link.springer.com/article/10.1007/s10462-022-10289-z
- Chen-Fu Chien et al., "Ensemble learning for demand forecast of After-Market spare parts to empower data-driven value chain and an empirical study," *Computers & Industrial Engineering*, 2023. [Online]. Available:

https://www.sciencedirect.com/science/article/abs/pii/S0360835223006940

- Mehr Alizad et al., "A Comparative Study of Clustering Methods for Nanoindentation Mapping Data," *Integrating Materials and Manufacturing Innovation*, 2024. [Online]. Available: https://www.researchgate.net/publication/379286289_A_Comparative_Study_of_Clustering_Method s_for_Nanoindentation_Mapping_Data
- Justin Nduhura Munga et al., "Industrial implementation of a dynamic sampling algorithm in semiconductor manufacturing: Approach and challenges," *Proceedings - Winter Simulation Conference*, 2012. [Online]. Available: https://www.researchgate.net/publication/261117855_Industrial_implementation_of_a_dynamic_sam pling algorithm in semiconductor manufacturing Approach and challenges
- Nuria Nievas et al., "Reinforcement Learning for Autonomous Process Control in Industry 4.0: Advantages and Challenges," *Applied Artificial Intelligence*, 2024. [Online]. Available: https://www.tandfonline.com/doi/full/10.1080/08839514.2024.2383101

Print ISSN: 2054-0957 (Print)

Online ISSN: 2054-0965 (Online)

Website: https://www.eajournals.org/

Publication of the European Centre for Research Training and Development -UK

- Domor I Mienye and Theo Swart, "A Comprehensive Review of Deep Learning: Architectures, Recent Advances, and Applications," *Information*, 2024. [Online]. Available: https://www.researchgate.net/publication/386204750_A_Comprehensive_Review_of_Deep_Learning _Architectures_Recent_Advances_and_Applications
- 9. David B. Olawade et al., "Artificial intelligence in environmental monitoring: Advancements, challenges, and future directions," *Hygiene and Environmental Health Advances*, 2024. [Online]. Available: https://www.sciencedirect.com/science/article/pii/S2773049224000278
- Yingjie Chen et al., "Digital Twins in Pharmaceutical and Biopharmaceutical Manufacturing: A Literature Review," *Processes*, 2020. [Online]. Available: https://www.mdpi.com/2227-9717/8/9/1088
- 11. Jianjun Zhou, "Optimization Algorithm of Intelligent Warehouse Management System Based on Reinforcement Learning," *Journal of Electrical Systems*, 2024. [Online]. Available: https://www.researchgate.net/publication/379688901_Optimization_Algorithm_of_Intelligent_Warehouse_Management_System_Based_on_Reinforcement_Learning
- Mohsen Soori et al., "Digital twin for smart manufacturing, A review," Sustainable Manufacturing and Service Economics, 2023. [Online]. Available: https://www.sciencedirect.com/science/article/pii/S2667344423000099